## Notice of References Cited Application/Control No. 09/987,881 Examiner Emmanuel Bayard Applicant(s)/Patent Under Reexamination SEKI ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,044,106	03-2000	Suzuki, Mitsuhiro	375/219
	В	US-5,959,965	09-1999	Ohkubo et al.	370/203
	С	US-6,744,828	06-2004	Uchiyama et al.	375/326
	D	US-6,341,123	01-2002	Tsujishita et al.	370/210
	E	US-6,148,045	11-2000	Taura et al.	375/344
	F	US-6,055,415	04-2000	Suzuki, Mitsuhiro	455/69
	G	US-6,587,510	07-2003	Minami et al.	375/285
	Н	US-6,130,859	10-2000	Sonnenschein et al.	367/134
		US-6,192,056	02-2001	Tsuruoka, Tatsuya	370/504
	J	US-5,771,224	06-1998	Seki et al.	·370/206
	к	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N				·	
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)							
	U								
	٧								
	w								
	×								

<sup>\*</sup>A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.